

Notice of References Cited	Application/Control No. 10/580,704		Applicant(s)/Patent Under Reexamination NAKAJIMA ET AL.	
	Examiner Marcus Charles		Art Unit 3682	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,259,637 A	03-1981	Bloomfield et al.	324/173
*	B	US-4,555,189 A	11-1985	Donkin, Charles W.	384/493
*	C	US-5,764,138 A	06-1998	Lowe, Peter R.	340/447
*	D	US-5,851,074 A	12-1998	Sakamoto, Junshi	384/448
*	E	US-5,898,388 A	04-1999	Hofmann et al.	340/870.31
*	F	US-5,986,448 A	11-1999	Yada et al.	324/173
*	G	US-6,002,248 A	12-1999	Binder, Josef	324/160
*	H	US-6,501,382 B1	12-2002	Rehfus et al.	340/572.8
*	I	US-6,559,633 B1	05-2003	Nachtigal et al.	324/174
*	J	US-2003/0093188 A1	05-2003	Morita et al.	340/438
*	K	US-2005/0089253 A1	04-2005	Koike et al.	384/448
*	L	US-7,011,451 B2	03-2006	Tajima et al.	384/448
*	M	US-7,320,258 B2	01-2008	Tawara, Hideo	384/448

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2004072747 A1	08-2004	World Intellect	NAKAMURA et al.	G05B 19/418
	O	JP 2004263724 A	09-2004	Japan	NAKAMURA et al.	F16C 33/58
	P	JP 10-315-669 A	12-1998	Japan	Kurachi et al.	B42D 15/10
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.